

# The Effects of Radiation Losses on the Measurement of Loss Tangent Using Microstrip Ring Resonators.

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# Motivation

- The loss tangent of a moisture absorbing material is linked to the moisture content.
- This can be utilized to find the moisture content through loss tangent measurements.
- This work resulted from a measurement technique developed to measure the moisture content of *transformer press boards*.

- Our focus was on the dielectrics in sheet form used in transformers used in power distribution networks.
- If the moisture content (in the dielectric insulation) is measured, the transformer failure can be predicted and the reliability can be improved.

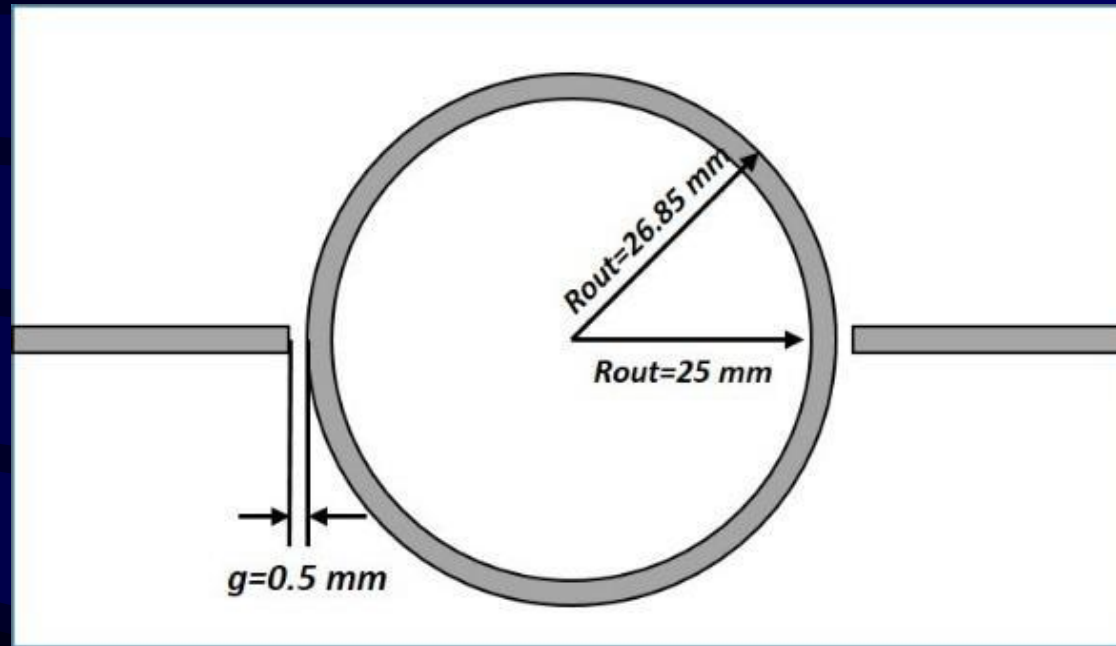
# Our application



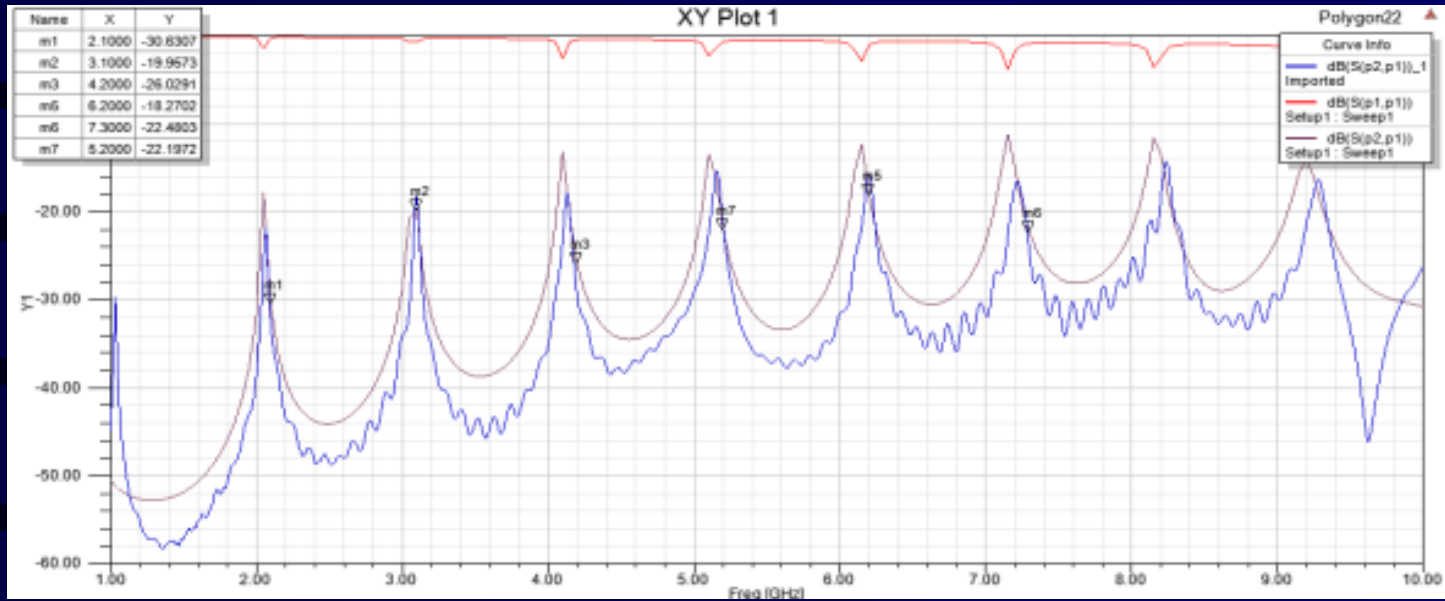
# Microstrip line based techniques

- We consider microstrip line based techniques at microwave frequencies.
- At microwave frequencies, the losses due to the presence of moisture are significant.

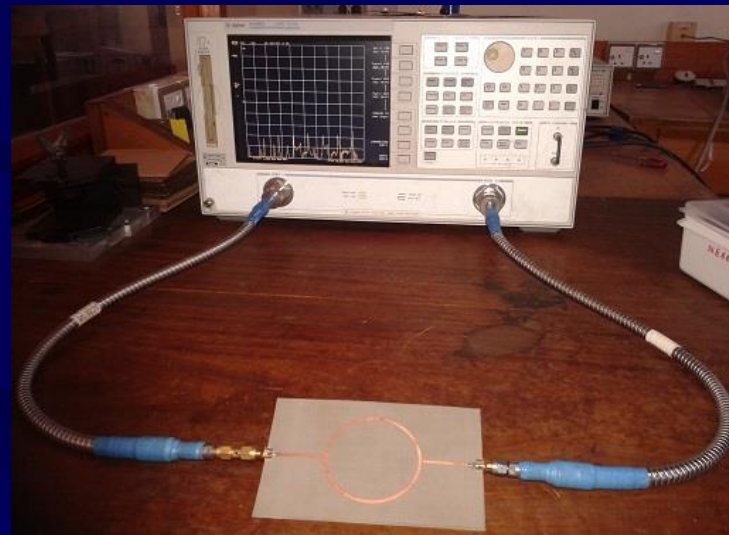
# Ring resonator technique



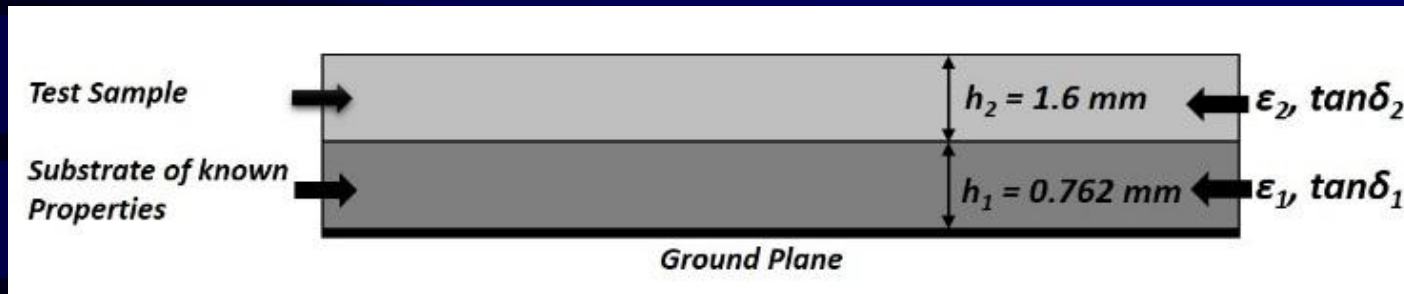
$$f_n = \frac{nc}{2\pi R_{mean} \sqrt{\epsilon_{reff}}} \quad \longrightarrow \quad \epsilon_{eff}$$



- Experimental set up and measured data.



# Multi-layer dielectric stack

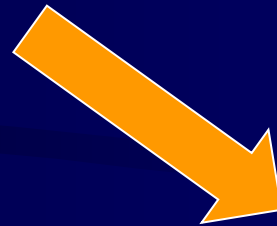


- Complications arise due to the multi-layer nature of the problem.



# Basis of calculations

$$\frac{1}{Q_u} = \frac{1}{Q_c} + \frac{1}{Q_r} + \frac{1}{Q_d}$$



$$Q_u = \frac{f_0}{(1 - |S_{21}|)B_{3dB}}$$

$Q_c$ : Hammerstad equations.

$Q_r$ : Neglect?

$$\tan \delta_{eff} = \frac{1}{Q_u}$$



$$\tan \delta_{eff} = \frac{1}{\epsilon_{reff}} \sum_{i=1}^2 p_i \tan \delta_i$$

**$p_i$ : Schneider's filling factor**

# Is radiation significant? The contribution of this paper.

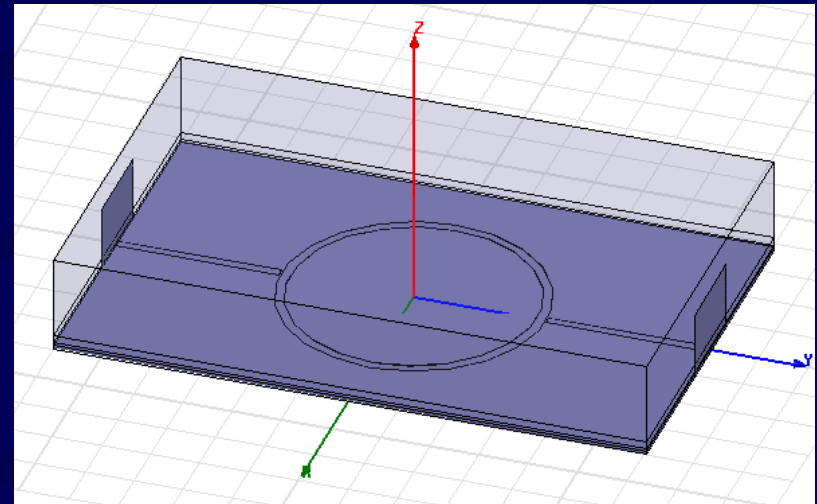
- Radiation losses are usually ignored in measurements.
- In some techniques, the radiation losses with and without the test sample are assumed to be equal and balanced out.

# Radiation loss

- Although difficult, analytical formulas can be obtained for the radiation from the ring structure. However, these techniques ignore the effects of the feeder lines and gaps.
- Measurement needs an anechoic chamber and are not suitable for low-cost dielectric measurements.

# Simulation using HFSS

- In this paper, we use finite element based EM simulation to accurately obtain the radiation losses.
- The solution gives  $\tilde{E}$  and  $\tilde{H}$  at every



# Finding Qs

- Constituant  $Q$  factors ( $Q_d$ ,  $Q_r$ , and  $Q_c$ ) and  $Q_u$  can be found since  $\tilde{E}$  and  $\tilde{H}$  are known.

$$Q = \frac{w_m + w_e}{P_l} \cdot \omega$$

$w_e, w_m$ : Average electrical/magnetic stored energy.

$P_l$ : Energy dissipation per second.

Stored energy densities in terms  
of field components:

$$w_m = \frac{1}{2} \operatorname{Re} \int (\tilde{B} \cdot \tilde{H}^*) dV$$

$$w_e = \frac{1}{2} \operatorname{Re} \int (\tilde{D} \cdot \tilde{E}^*) dV$$

# Energy densities in terms of field components:

$$P_{rad} = \frac{1}{2} \text{Re} \int (\tilde{\mathbf{E}} \times \tilde{\mathbf{H}}^*) dS$$

$$P_c = \frac{1}{2} \text{Re} \int (\tilde{\mathbf{J}} \cdot \tilde{\mathbf{E}}^*) dV$$

$$P_d = \frac{\omega}{2} \text{Re} \int (\tilde{\mathbf{D}} \cdot \tilde{\mathbf{E}}^*) dV$$



# Evaluation of integrals: HFSS field calculator

- `$begin 'Named_Expression'`
- `Name('DielectricLoss')`
- `Expression('+(Integrate(Volume(substrate), Volume_Loss_Density),  
Integrate(Volume(TestSample), Volume_Loss_Density))')`
- `NameOfExpression('Volume_Loss_Density')`
- `EnterVolume('substrate')`
- `Operation('VolumeValue')`
- `Operation('Integrate')`
- `NameOfExpression('Volume_Loss_Density')`
- `EnterVolume('TestSample')`
- `Operation('VolumeValue')`
- `Operation('Integrate')`
- `Operation('+')`
- `$end 'Named_Expression'`

# Results

<b>Resonant frequency</b>	<b>4.037 GHz</b>
3 dB Bandwidth	20 MHz
S21 at resonance	-23.96 dB
Conduction loss	8.5 mW
Dielectric loss	178.48 mW
Radiation loss	31.76 mW
Stored magnetic energy	$5.19 \times 10^{-7}$ mW
Stored electrical energy	$4.87 \times 10^{-7}$ mW

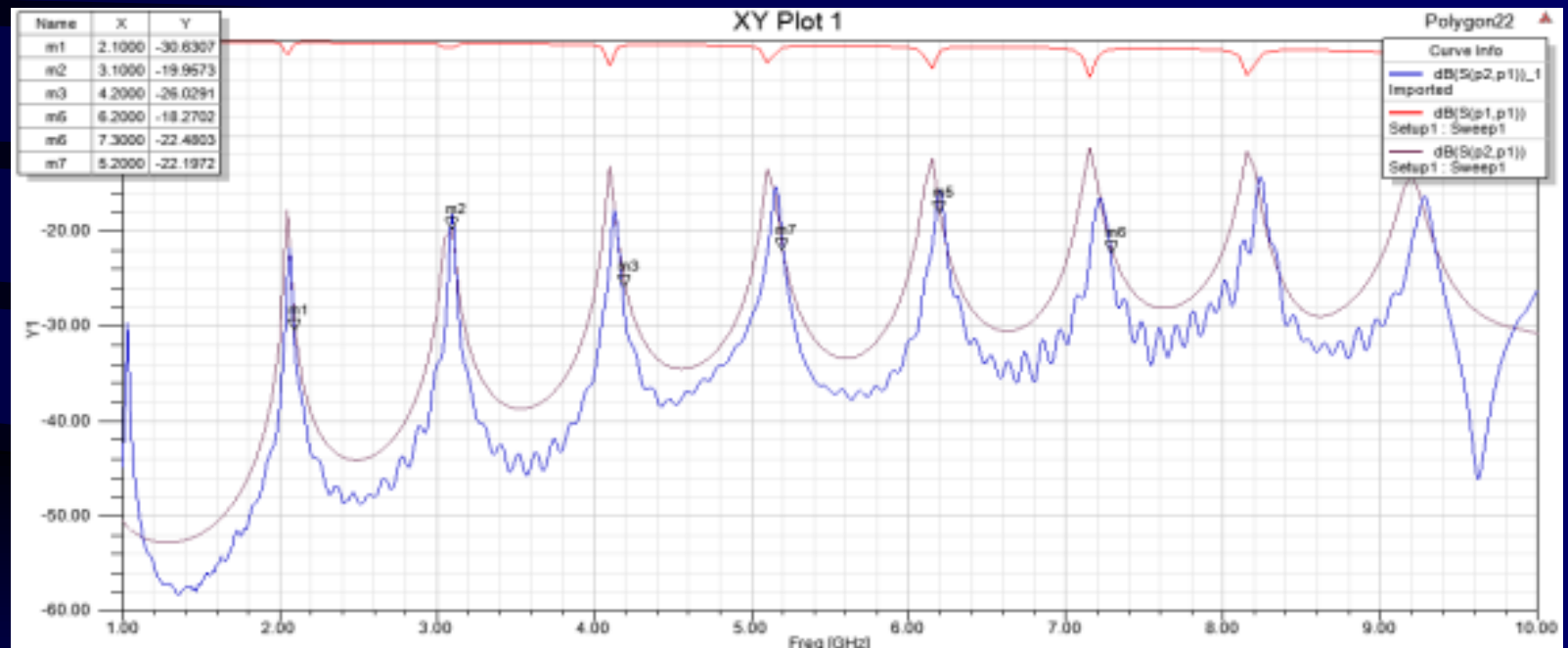
- Note: HFSS normalizes input power to 1W.

# Results

<b><math>Q_u</math> from and eigen-solution with HFSS</b>	<b>115.2</b>
$Q_u$ from stored energy and loss (equation 12 in the paper)	116.2
Effective permittivity (equation 5 in the paper)	3.33
Relative permittivity of the test sample	5.18
Loss tangent with radiation accounted	0.03
Loss tangent with radiation ignored	0.04

- How do we know the above results are correct?

# 1. Measured vs. simulated results



## 2. Cross check the value of $Q_u$

- Since we know  $w_e$ ,  $w_m$ ,  $P_c$ ,  $P_r$ , and  $P_d$  unloaded  $Q$  ( $Q_u$ ) can be calculated.
- Alternatively,  $Q_u$  can be obtained from an eigen solution.
- Method 1:  $Q_u = 116.2$
- Method 2:  $Q_u = 115.2$
- Error = 1.2 %

# Conclusion

- Results showed that the radiation, dielectric, and conductor losses amount to 3.9%, 81.6%, 14.5% in the simulated problem.
- Results further showed that ignoring the radiation loss resulted in a 33.3% error.

# On going work

- The above conclusions lead to focus our attention to strip-line based measurements which are free from radiation effects.
- The work presented is a part of a more detailed work which has been accepted for publication in August 2016, in IEEE transactions of Dielectrics and Insulators.

Thank you.